

SEP 27 2005

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Patent Application Serial No. .... 10/803,264  
Filing Date ..... March 17, 2004  
Inventor ..... Warren M. Farnworth  
Assignee ..... Micron Technology, Inc.  
Group Art Unit ..... 2829  
Examiner ..... Russell Marc Kobert  
Attorney Docket No. .... MI22-2524  
Customer No:..... 021567

Assistant Commissioner for Patents  
Washington, D.C. 20231

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Dated: 27 Sept 2005By: Rhonda G. Rambo

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Telephone No. (509) 624-4276

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Rhonda 

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Inventor ..... Warren M. Farnworth et al.  
Assignee ..... Micron Technology, Inc.  
Group Art Unit ..... 2829  
Examiner ..... Russell Marc Kobert  
Attorney Docket No. .... MI22-2524  
Title: Method and Apparatus for Testing Semiconductor Circuitry for Operability  
and Method of Forming Apparatus for Testing Semiconductor Circuitry for  
Operability

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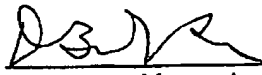
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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Patent Application Serial No. 10/803,264  
 Filing Date March 17, 2004  
 Inventor Warren M. Farnworth et al.  
 Assignee Micron Technology, Inc.  
 Group Art Unit 2829  
 Examiner Russell Marc Kobert  
 Attorney Docket No. M122-2524  
 Title: Method and Apparatus for Testing Semiconductor Circuitry for Operability  
 and Method of Forming Apparatus for Testing Semiconductor Circuitry for  
 Operability

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Date	Contents Description
07-08-2005	Mail Non-Final Rejection
07-07-2005	Non-Final Rejection
06-29-2005	Examiner Interview Summary Record (PTOL
07-07-2005	Date Forwarded to Examiner
06-29-2005	Amendment after Final Rejection
05-03-2005	Mail Final Rejection (PTOL - 326)
05-02-2005	Final Rejection
03-02-2005	Date Forwarded to Examiner
02-28-2005	Response after Non-Final Action
02-28-2005	Reference capture on IDS
02-28-2005	Information Disclosure Statement (IDS) Filed
02-25-2005	Miscellaneous Incoming Letter
10-11-2004	Reference capture on IDS
10-11-2004	Information Disclosure Statement (IDS) Filed
03-01-2005	Mail Examiner Interview Summary (PTOL - 4
02-23-2005	Examiner Interview Summary Record (PTOL - 4
11-29-2004	Mail Non-Final Rejection
11-23-2004	Non-Final Rejection
09-25-2004	Case Docketed to Examiner In GAU
09-01-2004	Case Docketed to Examiner in GAU
08-23-2004	Case Docketed to Examiner In GAU
08-06-2004	IFW TSS Processing by Tech Center Complete
08-06-2004	Case Docketed to Examiner in GAU
07-13-2004	Application Return from OIPE
07-13-2004	Application Return TO OIPE
07-13-2004	Application Dispatched from OIPE
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